

<b>Notice of References Cited</b>	Application/Control No. 10/539,366	Applicant(s)/Patent Under Reexamination TIEKE ET AL.	
	Examiner Aneeta Yodichkas	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,963,527	11-2005	Ohkura et al.	369/59.11
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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